

AO4459

30V P-Channel MOSFET

General Description

The AO4459 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}$. This device is ideal for load switch and battery protection applications.

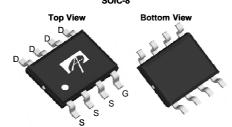
Product Summary

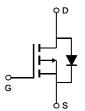
 $\begin{array}{lll} V_{DS} & -30V \\ I_{D} \; (at \; V_{GS} \!\!=\! \!\! -10V) & -6.5A \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\! -10V) & < 46m\Omega \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! \!\! -4.5V) & < 72m\Omega \end{array}$

100% UIS Tested 100% R_g Tested









Absolute Maximum Ratings T_A=25℃ unless otherwise noted

Parameter		Symbol	Maximum	Units	
Drain-Source Voltage		V _{DS}	-30	V	
Gate-Source Voltage		V _{GS}	±20	V	
Continuous Drain	T _A =25℃		-6.5		
Current	T _A =70℃	ID	-5.3	A	
Pulsed Drain Current ^C		I _{DM}	-30		
Avalanche Current ^C		I _{AS} , I _{AR}	17	А	
Avalanche energy L=0.1mH ^C		E _{AS} , E _{AR}	14	mJ	
T _A =25℃		P _D	3.1	W	
Power Dissipation ^B	T _A =70℃		2	vv	
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	C	

Thermal Characteristics								
Parameter		Symbol	Тур	Max	Units			
Maximum Junction-to-Ambient A	t ≤ 10s	D	31	40	℃/W			
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	59	75	℃/W			
Maximum Junction-to-Lead Steady-S		$R_{\theta JL}$	16	24	℃/W			



Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units				
STATIC PARAMETERS										
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = -250 \mu A, V_{GS} = 0 V$	-30			V				
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =-30V, V _{GS} =0V			-1	μA				
		T _J =55℃			-5	μΑ				
I_{GSS}	Gate-Body leakage current	V_{DS} =0V, V_{GS} = ±20V			±100	nA				
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS} I_{D}=-250\mu A$	-1.4	-1.9	-2.4	V				
$I_{D(ON)}$	On state drain current	V _{GS} =-10V, V _{DS} =-5V	-30			Α				
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-10V, I _D =-6.5A		33	46	mΩ				
		T _J =125℃		50	68	11122				
		V_{GS} =-4.5V, I_D =-5A		53	72	mΩ				
g _{FS}	Forward Transconductance	V_{DS} =-5V, I_{D} =-6.5A		14		S				
V_{SD}	Diode Forward Voltage	I _S =-1A,V _{GS} =0V		-0.8	-1	V				
I _S	Maximum Body-Diode Continuous Curr			-3.5	Α					
DYNAMIC	PARAMETERS									
C _{iss}	Input Capacitance			520		pF				
C _{oss}	Output Capacitance	V_{GS} =0V, V_{DS} =-15V, f=1MHz		100		pF				
C _{rss}	Reverse Transfer Capacitance			65		pF				
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	3.5	7.5	11.5	Ω				
SWITCHI	NG PARAMETERS									
Q _g (10V)	Total Gate Charge			9.2	11	nC				
Q _g (4.5V)	Total Gate Charge	V _{GS} =-10V, V _{DS} =-15V, I _D =-6.5A		4.6	6	nC				
Q_{gs}	Gate Source Charge	V _{GS} =-10V, V _{DS} =-15V, I _D =-0.5A		1.6		nC				
Q_{gd}	Gate Drain Charge]		2.2		nC				
t _{D(on)}	Turn-On DelayTime			7.5		ns				
t _r	Turn-On Rise Time	V_{GS} =-10V, V_{DS} =-15V, R_{L} =2.5 Ω ,		5.5		ns				
t _{D(off)}	Turn-Off DelayTime	$R_{GEN}=3\Omega$		19		ns				
t _f	Turn-Off Fall Time]		7		ns				
t _{rr}	Body Diode Reverse Recovery Time	I _F =-6.5A, dI/dt=100A/μs		11		ns				
Q_{rr}	Body Diode Reverse Recovery Charge	I _F =-6.5A, dI/dt=100A/μs		5.3		nC				

A. The value of $R_{\theta JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The value in any given application depends on the user's specific board design. B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using \leqslant 10s junction-to-ambient thermal resistance.

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C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initialT_{.1}=25° C.

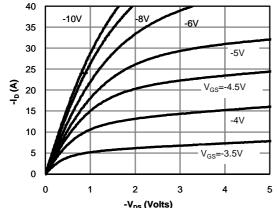
D. The $R_{\theta JA}$ is the sum of the thermal impedence from junction to lead $R_{\theta JL}$ and lead to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.

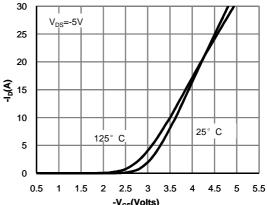
F. These curves are based on the junction-to-ambient thermal impedence which is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, assuming a maximum junction temperature of $T_{J(MAX)}$ =150 $^{\circ}$ C. The SOA curve provides a single pulse rating.



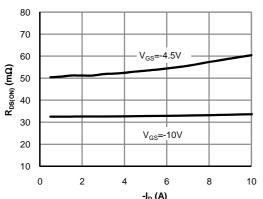
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



-V_{DS} (Volts) Fig 1: On-Region Characteristics (Note E)



-V_{GS}(Volts) Figure 2: Transfer Characteristics (Note E)



-I_D (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

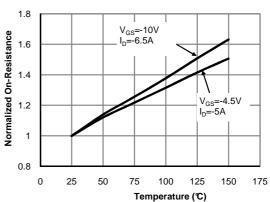
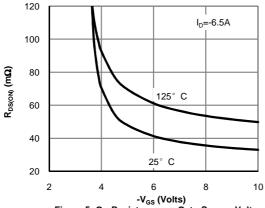
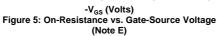
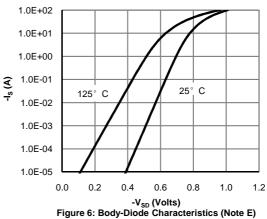


Figure 4: On-Resistance vs. Junction Temperature (Note E)

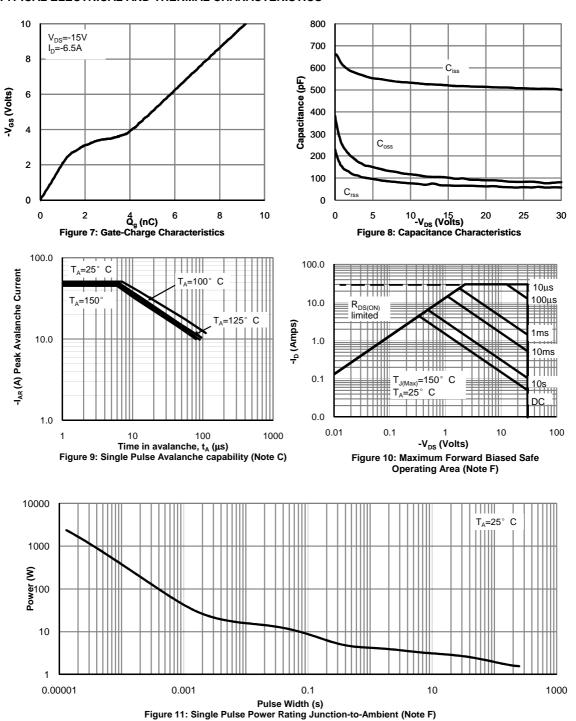






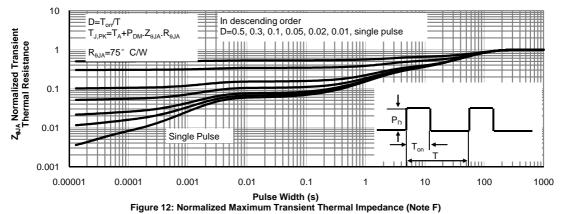


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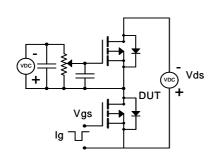


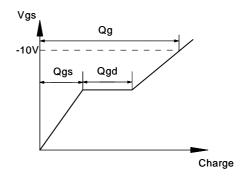
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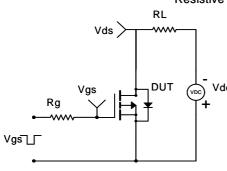


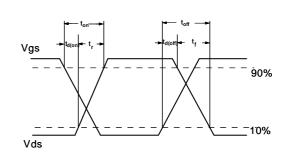
Gate Charge Test Circuit & Waveform



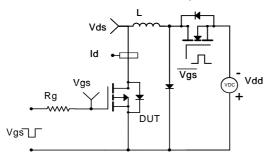


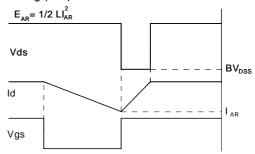
Resistive Switching Test Circuit & Waveforms





Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms

